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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.
10/665,616	09/22/2003	Masamitsu Itoh	4329.2543-01	6561
22852	7590	02/12/2004	EXAMINER	
FINNEGAN, HENDERSON, FARABOW, GARRETT & DUNNER LLP 1300 I STREET, NW WASHINGTON, DC 20005				WALKE, AMANDA C
ART UNIT		PAPER NUMBER		
		1752		

DATE MAILED: 02/12/2004

Please find below and/or attached an Office communication concerning this application or proceeding.

Office Action Summary	Application No.	Applicant(s)
	10/665,616	ITOH ET AL.
	Examiner Amanda C Walke	Art Unit 1752

-- The MAILING DATE of this communication appears on the cover sheet with the correspondence address --

Period for Reply

A SHORTENED STATUTORY PERIOD FOR REPLY IS SET TO EXPIRE 3 MONTH(S) FROM THE MAILING DATE OF THIS COMMUNICATION.

- Extensions of time may be available under the provisions of 37 CFR 1.136(a). In no event, however, may a reply be timely filed after SIX (6) MONTHS from the mailing date of this communication.
- If the period for reply specified above is less than thirty (30) days, a reply within the statutory minimum of thirty (30) days will be considered timely.
- If NO period for reply is specified above, the maximum statutory period will apply and will expire SIX (6) MONTHS from the mailing date of this communication.
- Failure to reply within the set or extended period for reply will, by statute, cause the application to become ABANDONED (35 U.S.C. § 133). Any reply received by the Office later than three months after the mailing date of this communication, even if timely filed, may reduce any earned patent term adjustment. See 37 CFR 1.704(b).

Status

1) Responsive to communication(s) filed on 22 September 2003.

2a) This action is **FINAL**. 2b) This action is non-final.

3) Since this application is in condition for allowance except for formal matters, prosecution as to the merits is closed in accordance with the practice under *Ex parte Quayle*, 1935 C.D. 11, 453 O.G. 213.

Disposition of Claims

4) Claim(s) 1-6 is/are pending in the application.
 4a) Of the above claim(s) _____ is/are withdrawn from consideration.

5) Claim(s) _____ is/are allowed.

6) Claim(s) 1-6 is/are rejected.

7) Claim(s) _____ is/are objected to.

8) Claim(s) _____ are subject to restriction and/or election requirement.

Application Papers

9) The specification is objected to by the Examiner.

10) The drawing(s) filed on 22 September 2003 is/are: a) accepted or b) objected to by the Examiner.

Applicant may not request that any objection to the drawing(s) be held in abeyance. See 37 CFR 1.85(a).

Replacement drawing sheet(s) including the correction is required if the drawing(s) is objected to. See 37 CFR 1.121(d).

11) The oath or declaration is objected to by the Examiner. Note the attached Office Action or form PTO-152.

Priority under 35 U.S.C. § 119

12) Acknowledgment is made of a claim for foreign priority under 35 U.S.C. § 119(a)-(d) or (f).
a) All b) Some * c) None of:
1. Certified copies of the priority documents have been received.
2. Certified copies of the priority documents have been received in Application No. 09/812,688.
3. Copies of the certified copies of the priority documents have been received in this National Stage application from the International Bureau (PCT Rule 17.2(a)).

* See the attached detailed Office action for a list of the certified copies not received.

Attachment(s)

1) Notice of References Cited (PTO-892) 4) Interview Summary (PTO-413)
2) Notice of Draftsperson's Patent Drawing Review (PTO-948) Paper No(s)/Mail Date. _____.
3) Information Disclosure Statement(s) (PTO-1449 or PTO/SB/08)
Paper No(s)/Mail Date 9/22/03. 5) Notice of Informal Patent Application (PTO-152)
6) Other: _____.

DETAILED ACTION

1. This action is in response to the application and the preliminary amendment filed on 9/22/2003. In the amendment, claims 7-19 were canceled leaving only claims 1-6 pending.

Priority

2. This application appears to be a division of Application No. 09/812688, filed 3/21/2001. A later application for a distinct or independent invention, carved out of a pending application and disclosing and claiming only subject matter disclosed in an earlier or parent application is known as a divisional application or "division." The divisional application should set forth only that portion of the earlier disclosure which is germane to the invention as claimed in the divisional application.

Acknowledgment is made of applicant's claim for foreign priority under 35 U.S.C. 119(a)-(d).

The certified copy has been filed in parent Application No. 09/812688, filed on 3/21/2001.

Claim Rejections - 35 USC § 103

3. The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:

(a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negated by the manner in which the invention was made.

4. Claims 1-6 are rejected under 35 U.S.C. 103(a) as being unpatentable over Masataka (JP 11-271965 Patent Abstracts of Japan and partial machine translation) in view of Sato et al (JP 08-262721 Patent Abstracts of Japan).

Masataka discloses a pattern formation method utilizing a positive type chemical amplification resist containing a polymer having an acid dissociation group of an acetal type, coating the resist on a substrate, then exposing the resist in a vacuum by e-beam exposure, and finally developing the resist to form a pattern. A suitable polymer is poly(ethoxy ethyloxy styrene (35 mol %))/ hydroxy styrene (65 mol %). The photoresist composition further comprises a photoacid generator and a solvent ([0002] to [0008] and [0011] to [0016]).

Sato et al disclose a positive type resist composition having high sensitivity, high resolution, and high heat resistance, excellent in aging stability, and capable of forming a resist pattern excellent in profile shape (see abstract and page 3 of the present specification). This is achieved by replacing 10-60 mol% of the hydroxyl groups of a poly hydroxy styrene polymer with tert-butoxycarbonyloxy groups.

Given the teaching of the Sato reference that replacing the hydroxyl groups of a poly hydroxy styrene polymer with tert-butoxycarbonyloxy groups results in increased aging stability and a pattern having excellent profile shape, it would have been obvious to one of ordinary skill in the art to prepare the material of Masataka by the method of Masataka, choosing the replace 10-60 mol % of the hydroxyl groups of the hydroxy styrene polymer with tert-butoxycarbonyloxy groups to achieve the advantages discussed above, with reasonable expectation of achieving a resist pattern having a good pattern shape.

With respect to the limitation of the present claim 1 requiring a step of determining a ratio of the two dissolution inhibiting groups, as discussed in applicant's Background of the Invention, e-beam exposure is a step and repeat procedure wherein the material is exposed portion-by-portion over a period of time which may be 10 hours or longer. This means that, for

example, the first area exposed with the desired pattern would be "T" and the last would be "T+ 10 hours". Given that the references discuss obtaining a resist that provides excellent aging stability and excellent resist image profile, one of ordinary skill in the art would have been motivated to maximize that ratio of the two groups to achieve the best image profile. Additionally, it is not clear as to what the expected ratio should be, thus it is not clear what amounts of each would produce the desired result, it is the position of the examiner that one of ordinary skill in the art would utilize a step of determining the optimal ratio of hydroxyl groups and tert-butoxycarbonyloxygroups to acetal groups by determining where the image profile is unchanged over time in order to optimize the image prepared.

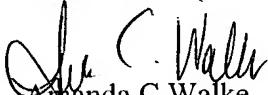
***** Given that both references are JP documents and the examiner does not possess full translations of either at this time, the examiner would like to note that translations of both documents have been requested, but are unavailable at this time.

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Amanda C Walke whose telephone number is 571-272-1337. The examiner can normally be reached on M-R 5:30-4.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Mark Huff can be reached on 571-272-1385. The fax phone number for the organization where this application or proceeding is assigned is 703-872-9306.

Art Unit: 1752

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see <http://pair-direct.uspto.gov>. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).



Amanda C. Walke
Examiner
Art Unit 1752

ACW
February 4, 2004